CORRECTION



## Correction: A Broken FEEC Framework for Electromagnetic Problems on Mapped Multipatch Domains

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## Correction to: Journal of Scientific Computing (2023) 97:52 https://doi.org/10.1007/s10915-023-02351-x.

In this article the city and university name in affiliations details were incorrectly published. That is,

- 1. "Garching bei, München" should be "Garching bei München" in both the affiliations.
- 2. "Technische Universität Cheney" should be "Technische Universität München".

The original article has been updated.

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